

**Notice of References Cited**

Application/Control No.

10/712,955

Applicant(s)/Patent Under

Reexamination

HALLAK-STAMLER, MICHELE

Examiner

Anil N. Kumar

Art Unit

2109

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,394,522 A	02-1995	Sanchez-Frank et al.	715/735
*	B	US-5,684,967 A	11-1997	McKenna et al.	715/853
*	C	US-6,009,466 A	12-1999	Axberg et al.	709/220
*	D	US-6,346,954 B1	02-2002	Chu et al.	715/764
*	E	US-6,496,914 B1	12-2002	Vook et al.	711/170
*	F	US-2003/0051021 A1	03-2003	Hirschfeld et al.	709/223
*	G	US-6,538,669 B1	03-2003	Lagueux et al.	715/764
*	H	US-6,757,778 B1	06-2004	van Rietschote, Hans F.	711/6
*	I	US-6,748,502 B2	06-2004	Watanabe et al.	711/158
*	J	US-6,880,002 B2	04-2005	Hirschfeld et al.	709/223
*	K	US-2005/0251567 A1	11-2005	Ballew et al.	709/223
*	L	US-6,977,927 B1	12-2005	Bates et al.	370/381
*	M	US-7,107,328 B1	09-2006	Muthiyan et al.	709/220

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.